

FORM PTO-1449

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY. DOCKET NO.
THIBAUT1.001APPLICATION NO.
10/550,780List of Information Cited by Applicant
(Use several sheets if necessary)APPLICANTS
Jacques THIBAUT, ET AL.FILING DATE
September 27, 2005GROUP
(not yet assigned)

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
CW	AA	5 7 1 6 0 4 5	02/10/98	Taylor			
	AB	4 0 1 6 7 8 4	04/12/77	Brown			
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
CW	AL	1 1 5 7 7 7 8	11/28/01	EPO				
	AM	0 6 4 6 4 3 8	04/05/95	EPO				
	AN	2 8 5 2 8 7 6	10/01/04	France				
	AO	60 1 2 7 9 5 8	07/08/85	Japan				
	AP	09 1 5 5 6 9 3	06/17/97	Japan				

OTHER INFORMATION (Including Author, Title, Date, Pertinent Pages, Etc.)

CW	AR	Patent Abstracts of Japan, vol. 009, No. 286 (M-429), Published: November 13, 1985 (citing JP 60 127958)
	AS	Patent Abstracts of Japan, vol. 1997, No. 10, Published: October 31, 1997 (citing JP 09 155693)
	AT	

EXAMINER

Wilson

DATE CONSIDERED

11/29/06

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not conformance and not considered. Include copy of this form with next communication to applicant.

FORM PTO-1449	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DOCKET NO. THIBAUT1.D02	APPLICATION NO. 10/550,780
List of Information Cited by Applicant (Use several sheets if necessary)		APPLICANTS Jacques THIBAUT, ET AL.	
		FILING DATE September 27, 2005	GROUP 3723

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CENTRAL EXAMINER
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U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
W	AA	6 4 3 8 8 5 7	08/27/02	Jacobs et al.			
	AB	4 8 9 5 4 5 4	01/23/90	Kammleiter et al.			
	AC	3 8 2 3 4 8 2	07/16/74	Schiler			
	AD	3 7 7 4 3 1 1	11/27/73	Stemple			
	AE	3 7 4 0 8 5 6	06/26/73	Culver			
	AF						
	AG						
	AH						
	AI						
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